

# HM30P55I-VB Datasheet

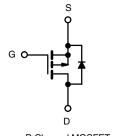
P-Channel 60 V (D-S) 175 °C MOSFET

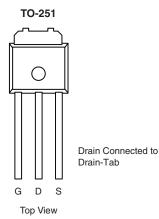
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	- 60			
$R_{DS(on)} (\Omega)$ at $V_{GS}$ = - 10 V	0.0135			
$R_{DS(on)} (\Omega)$ at $V_{GS} = -4.5 V$	0.017			
I <sub>D</sub> (A)	- 50			
Configuration	Single			

## **FEATURES**

- Trench Power MOSFET
- Package with Low Thermal Resistance
- 100 %  $\rm R_g$  and UIS Tested







ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	- 60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
Continuous Drain Current <sup>a</sup>	T <sub>C</sub> = 25 °C	I	- 50		
Continuous Drain Current <sup>a</sup>	T <sub>C</sub> = 125 °C	- I <sub>D</sub>	- 38		
Continuous Source Current (Diode Conduction) <sup>a</sup>		IS	- 50	А	
Pulsed Drain Current <sup>b</sup>		I <sub>DM</sub>	- 200		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 52		
Single Pulse Avalanche Energy	L = 0.1 MH	E <sub>AS</sub>	135	mJ	
Maximum Power Dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	D	136	W	
	T <sub>C</sub> = 125 °C	P <sub>D</sub>	45	٧V	
Operating Junction and Storage Temperature Ran	ge	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	

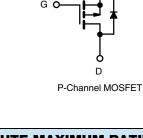
THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-Ambient	PCB Mount <sup>c</sup>	R <sub>thJA</sub>	50	°C/W		
Junction-to-Case (Drain)		R <sub>thJC</sub>	1.1	0/10		

Notes

a. Package limited.

b. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

c. When mounted on 1" square PCB (FR-4 material).



PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
	STINIBUL	TES	IVIIIN.	ITP.	WAA.	UNIT	
Static			01/1 050 4	- 60			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	do	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA		-	-	v
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	-	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$		-	- 2.5	
Gate-Source Leakage	I <sub>GSS</sub>	-	$V_{DS} = 0 V, V_{GS} = \pm 20 V$		-	± 100	nA
		$V_{GS} = 0 V$	V <sub>DS</sub> = - 60 V	-	-	- 1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	$V_{DS} = -60 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$	-	-	- 50	μA
		$V_{GS} = 0 V$	$V_{DS}$ = - 60 V, $T_J$ = 175 $^\circ C$	-	-	- 150	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{GS} = -10 V$	$V_{DS} \ge$ - 5 V	- 50	-	-	А
		V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 17 A	-	0.0135	-	Ω
Durin Course On Otata Desistence	P	$V_{GS} = -10 V$	I <sub>D</sub> = - 50 A, T <sub>J</sub> = 125 °C	-	0.026	-	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 50 A, T <sub>J</sub> = 175 °C	-	0.032	-	
		V <sub>GS</sub> = - 4.5 V	I <sub>D</sub> = - 14 A	-	0.017	-	
Forward Transconductancea	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 17 A		-	50	-	S
Dynamic <sup>b</sup>	-						
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V V <sub>DS</sub> = - 25 V, f = 1 MHz	-	4730	5910	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 V$		-	485	606	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			-	330	410	
Total Gate Charge <sup>c</sup>	Qg			-	98	150	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	V <sub>GS</sub> = - 10 V	V <sub>DS</sub> = - 30 V, I <sub>D</sub> = - 50 A	-	15	23	nC
Gate-Drain Charge <sup>c</sup>	Q <sub>qd</sub>				21	32	1
Gate Resistance	Rg	f = 1 MHz		1.47	2.9	4.42	Ω
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			-	15	18	
Rise Time <sup>c</sup>	tr	$V_{DD}$ = - 30 V, R <sub>L</sub> = 0.6 $\Omega$ I <sub>D</sub> $\cong$ - 50 A, V <sub>GEN</sub> = - 10 V, R <sub>g</sub> = 6.0 $\Omega$		-	12	16	ns
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>			-	112	125	
Fall Time <sup>c</sup>	t <sub>f</sub>			-	39	48	
Source-Drain Diode Ratings and Characteristics <sup>b</sup>							1
Pulsed Current <sup>a</sup>	I <sub>SM</sub>			-	-	- 200	А
Forward Voltage	V <sub>SD</sub>		- 50 A, V <sub>GS</sub> = 0 V	_	- 0.8	- 1.5	V

Notes

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

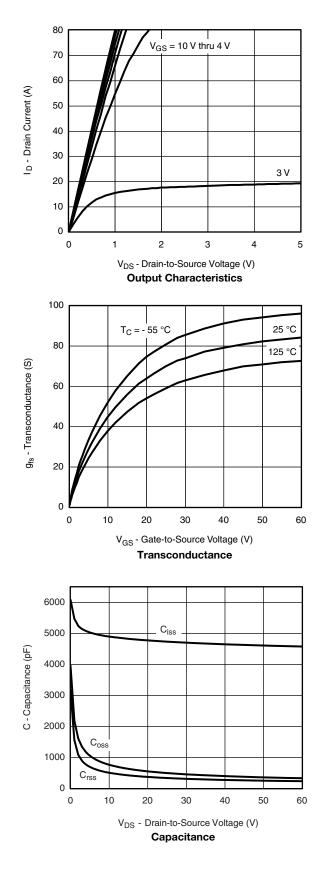
c. Independent of operating temperature.

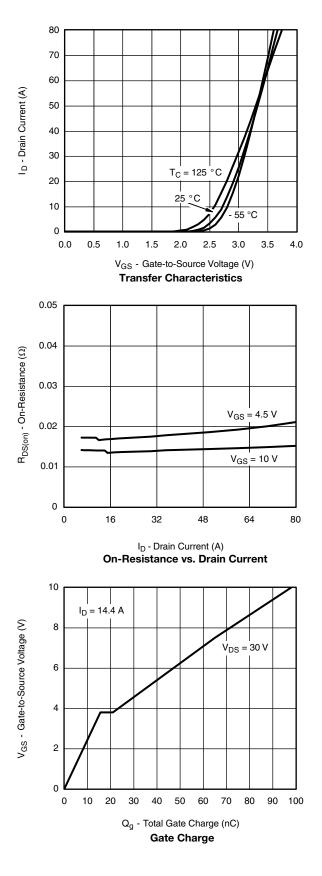
Bsemi

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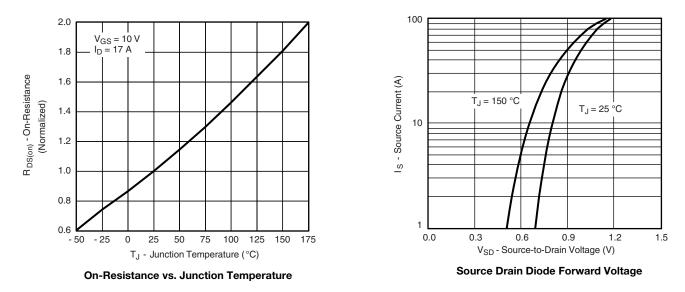


## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)

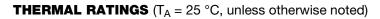


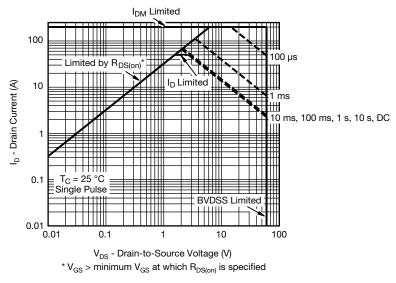






## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)

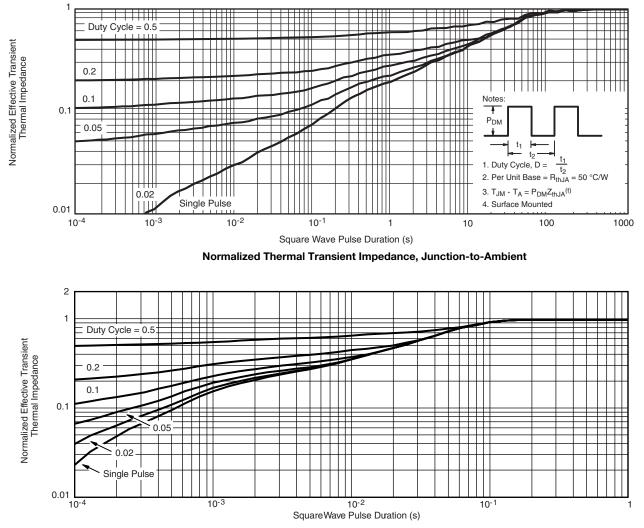








### **THERMAL RATINGS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

#### Note

• The characteristics shown in the two graphs

- Normalized Transient Thermal Impedance Junction to Ambient (25 °C)

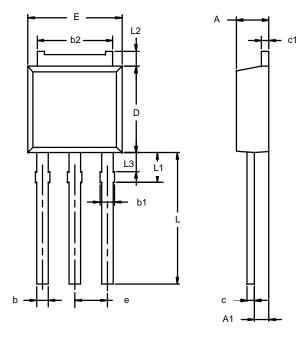
- Normalized Transient Thermal Impedance Junction to Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

# HM30P55I-VB



#### **TO-251AA**



	MILLIN	IETERS	INCHES		
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
A1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
c1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28	BSC	0.090	BSC	
L	3.89	9.53	0.153	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27 0.035		0.050	
L3	1.15	1.52	0.045	0.060	

Note: Dimension L3 is for reference only.



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